

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/557,287 OTAKA ET AL.	
		Examiner	Art Unit MARIA EL-ZOOBI	2614      Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0047867	04-2002	Mault et al.	345/810
*	B	US-2002/0083022	06-2002	Algazi, Allan Stuart	705/408
*	C	US-2003/0198383	10-2003	Yamaguchi et al.	382/183
*	D	US-7,088,859	08-2006	Yamaguchi et al.	382/181
*	E	US-2003/0014315	01-2003	Jaalinoja et al.	705/18
*	F	US-2003/0214529	11-2003	Martin et al.	345/738
*	G	US-2004/0017945	01-2004	Ihara et al.	382/182
*	H	US-2006/0113390	06-2006	Muramatsu, Takeharu	235/462.27
*	I	US-2006/0262012	11-2006	Nishikata et al.	342/357.11
*	J	US-6,330,975	12-2001	Bunte et al.	235/470
*	K	US-2002/0006786	01-2002	Mine, Takashi	455/414
*	L	US-2004/0111320	06-2004	Schlieffers et al.	705/016
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.